Appl. No. 10/624,406 Attorney Docket: 042390.P10735D

LISTING OF THE CLAIMS:

This listing of claims replaces all prior versions, and listings, of claims in the application:

- 1 1. (Withdrawn) A system comprising:
- a source of substantially spin-polarized electrons; and
- a medium which interacts with the spin-polarized electrons, the medium including a spin-
- 4 dependent quantum well and a layer of semi-conductor material capable of emitting photons.
- 1 2. (Withdrawn) The system of claim 1, wherein the layer of semi-conductor material comprises
- 2 a layer of N-type semi-conductor and a layer of P-type semi-conductor coupled so as to form a
- 3 P-N junction.
- 1 3. (Withdrawn) The system of claim 2, wherein the P-N junction comprises an electron excited
- 2 light emitting structure.
- 4. (Withdrawn) The system of claim 3, wherein the layer of semi-conductor material comprises
- 2 Gallium-Arsenic (GaAs).
- 1 5. (Withdrawn) The system of claim 4, wherein the spin-dependent quantum well is
- 2 substantially opaque to the photons emitted, during operation, by the layer of semi-conductor
- 3 material.
- 1 6. (Withdrawn) The system of claim 1, wherein the spin-dependent quantum well comprises a
- 2 layer of layer of magnetic material sandwiched between a first and second layers of spin mirror
- 3 materials.

- 1 7. (Withdrawn) The system of claim 6, further including:
- 2 a first layer of a electrically conductive material between the first layer of spin mirror
- 3 material and the layer of hard magnetic material; and,
- 4 a second layer of electrically conductive material below the layer of semi-conductor
- 5 material.
- 8. (Withdrawn) The system of claim 7, wherein the second layer of electrically conductive
- 2 material is substantially thin to allow photons emitted, during operation, by the layer of semi-
- 3 conductor material to pass through the second layer of electrically conductive material.
- 9. (Withdrawn) The system of claim 7, wherein the second layer of electrically conductive
- 2 material, at least partially, reflects the photons emitted, during operation, by the semi-conductor
- 3 material.
- 1 10. (Withdrawn) A method for reading the spin state of a magnetic domain comprising:
- directing at the magnetic domain a beam of electrons substantially polarized in a
- 3 particular spin state; and
- 4 detecting the light emission state of a semi-conductor layer of the magnetic domain.
- 1 11. (Withdrawn) The method of claim 10, wherein detecting the light emission state comprises
- 2 capturing at least a portion of the emitted photons utilizing a sensitive photo-detector.

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1 12. (Withdrawn) The method of claim 10, further comprising determining the state of the

- 2 magnetic domain, based in, part upon the light emission state.
- 1 13. (Withdrawn) The method of claim 12, wherein determining the state of the magnetic
- 2 domain comprises comparing the spin state of the beam of electrons to the light emission state of
- 3 the semi-conductor layer.
- 1 14. (Withdrawn) The method of claim 12, further comprising trapping a portion of the beam in
- 2 the magnetic domain.
- 1 15. (Withdrawn) The method of claim 14, wherein determining the state of the magnetic
- 2 domain comprises determining what the state of the magnetic domain was prior to trapping a
- 3 portion of the beam in the magnetic domain.
- 1 16. A system for reading data comprising:
- 2 a source of spin polarized electrons;
- a storage medium disposed a selected distance from the source and having a plurality of
- 4 storage locations, each storage location including a magnetic material and a layer of semi-
- 5 conductor material capable of emitting photons; and
- a photo-detector to detect the emitted photons.
- 1 17. The system of claim 16, wherein the magnetic material of the storage location includes a
- 2 spin-dependent quantum well.

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1 18. The system of claim 16, wherein the layer semi-conductor material of the storage location

- 2 includes a P-N junction.
- 1 19. The system of claim 16, wherein the layer semi-conductor material of the storage location
- 2 includes Gallium-Arsenic (GaAs).
- 1 20: The system of claim 16, further comprising a vacuum housing.
- 1 21: The system of claim 20, wherein the vacuum housing is at least partially reflective, so as to
- 2 facilitate the integration of the emitted photons.
- 1 22: The system of claim 16, wherein the magnetic material of the storage location is
- 2 substantially opaque to the photons emitted, during operation, by the layer of semi-conductor
- 3 material.
 - 23 30. (Cancelled).